


<b>Search Notes</b> 	<b>Application/Control No.</b> 10648229	<b>Applicant(s)/Patent Under Reexamination</b> CHEN ET AL.
	<b>Examiner</b> Seye, Abdou K	<b>Art Unit</b> 2194

SEARCHED			
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SEARCH NOTES		
Search Notes	Date	Examiner
East text search, inventor search, assignee search	2006/12/28	Abdou Seye

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